

MOS FIELD EFFECT TRANSISTOR NP88N055CHE, NP88N055DHE, NP88N055EHE

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance RDS(on) = 5.3 m Ω MAX. (Vgs = 10 V, ID = 44 A)
- Low Ciss: Ciss = 7600 pF TYP.
- Built-in gate protection diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
NP88N055CHE	TO-220AB
NP88N055DHE	TO-262
NP88N055EHE	TO-263

(TO-220AB)



(TO-262)



(TO-263)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage	V _{DSS}	55	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC) Note1	I _{D(DC)}	±88	Α
Drain Current (Pulse) Note2	I _{D(pulse)}	±352	Α
Total Power Dissipation (T _A = 25°C)	PT	1.8	W
Total Power Dissipation (Tc = 25°C)	PT	288	W
Single Avalanche Current Note3	las	65 / 88	Α
Single Avalanche Energy Note3	Eas	422 / 15	mJ
Channel Temperature	Tch	175	°C
Storage Temperature	T_{stg}	-55 to +175	°C

Notes 1. Calculated constant current according to MAX. allowable channel temperature.

- **2.** PW \leq 10 μ s, Duty cycle \leq 1 %
- 3. Starting T_{ch} = 25°C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V (See Figure 4.)

THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	0.52	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

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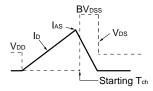


ELECTRICAL CHARACTERISTICS (TA = 25°C)

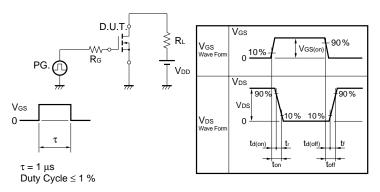
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, ID = 44 A		4.2	5.3	mΩ
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 44 A	30	60		S
Drain Leakage Current	Inss	V _{DS} = 55 V, V _{GS} = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	Vps = 25 V		7600	11400	pF
Output Capacitance	Coss	V _{GS} = 0 V		1100	1700	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		480	870	pF
Turn-on Delay Time	td(on)	ID = 44 A		42	93	ns
Rise Time	tr	V _{GS(on)} = 10 V		26	66	ns
Turn-off Delay Time	td(off)	VDD = 28 V		120	240	ns
Fall Time	tf	$R_G = 1 \Omega$		32	81	ns
Total Gate Charge	Q _G	ID = 88 A		130	200	nC
Gate to Source Charge	Qgs	V _{DD} = 44 V		31		nC
Gate to Drain Charge	Q _{GD}	Ves = 10 V		49		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 88 A, VGS = 0 V		1.0		V
Reverse Recovery Time	t rr	IF = 88 A, VGS = 0 V		62		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		120		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \Omega \\ \text{Vgs} = 20 \rightarrow 0 \text{ V} \\ \end{array}$



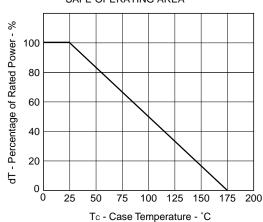
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

TYPICAL CHARACTERISTICS (TA = 25°C)

Figure1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



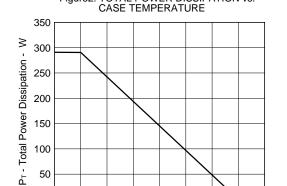


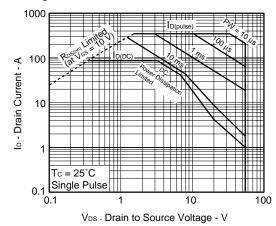
Figure 2. TOTAL POWER DISSIPATION vs.

100 Tc - Case Temperature - °C

125

175

Figure 3. FORWARD BIAS SAFE OPERATING AREA





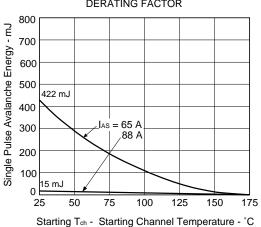


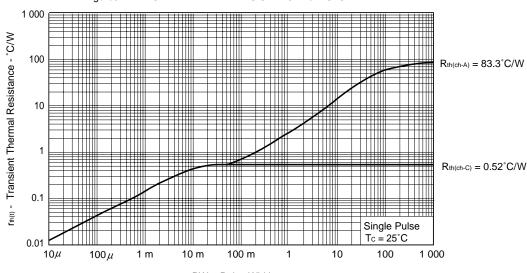
Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

50

0

25

50 75



PW - Pulse Width - s

Figure 6. FORWARD TRANSFER CHARACTERISTICS

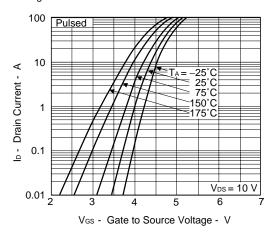


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

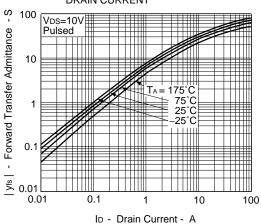


Figure 7. DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE

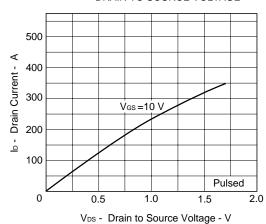


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

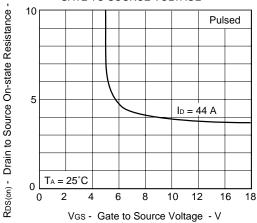
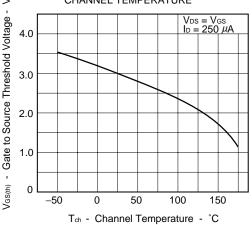
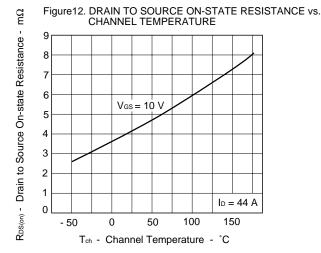
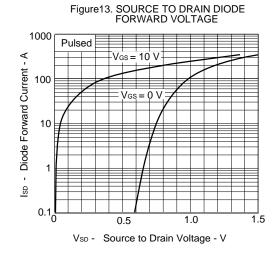
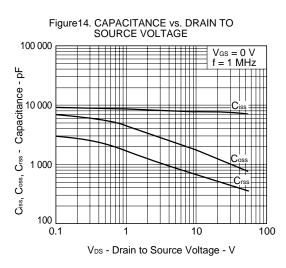


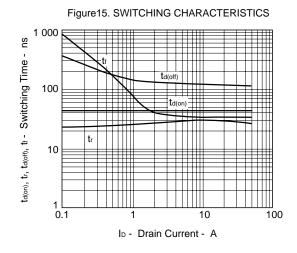
Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

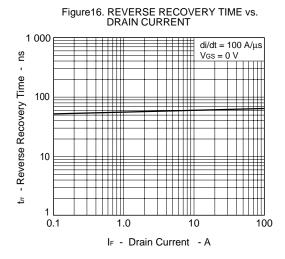


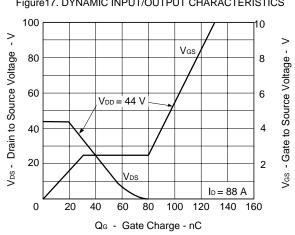






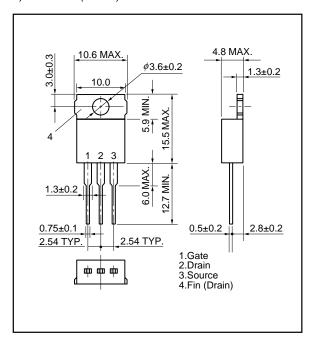




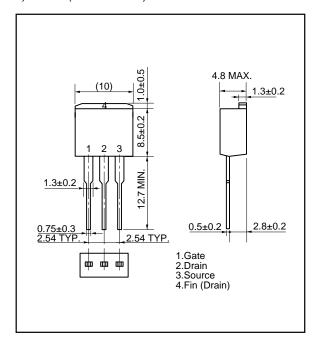


PACKAGE DRAWINGS (Unit: mm)

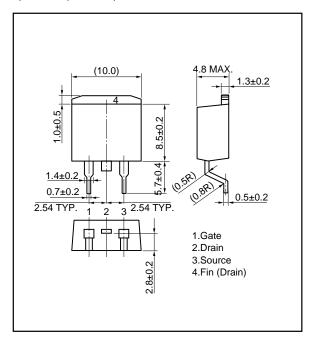
1) TO-220AB (MP-25)



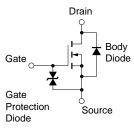
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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